

AMC1035 Delta-Sigma Modulator

With Bipolar Input of ± 1 V and Reference Output of 2.5 V

1 Features

- Delta-Sigma Modulator Optimized for Voltage and Temperature Sensing:
 - ± 1 -V Input Voltage Range
 - High Input Resistance: 1 G Ω (typ)
 - Integrated 2.5-V, ± 5 -mA Reference for Ratiometric Measurement
- Excellent DC Performance:
 - Offset Error: ± 0.5 mV (max)
 - Offset Drift: ± 8 μ V/ $^{\circ}$ C (max)
 - Gain Error: $\pm 0.2\%$ (max)
 - Gain Drift: ± 40 ppm/ $^{\circ}$ C (max)
- Selectable Manchester Encoded or Uncoded Bitstream Output
- Fully Specified Over the Extended Industrial Temperature Range: -40° C to $+125^{\circ}$ C

2 Applications

- AC Voltage and Temperature Sensing in Industrial Applications:
 - Motor Drives
 - Photovoltaic Inverters
 - Uninterruptible Power Supplies
 - Industrial Transport Systems

3 Description

The AMC1035 is a precision, delta-sigma ($\Delta\Sigma$) modulator that operates from a single 3.0-V to 5.5-V supply and with an externally supplied clock signal in the range of 9 MHz to 21 MHz.

The differential ± 1 -V input structure of the device is optimized for high noise environments typical for industrial applications.

Select the output bitstream of the AMC1035 to be Manchester coded to prevent setup and hold time requirement considerations of the receiving device and reduce overall circuit layout efforts. When used with a digital filter (such as integrated in the [TMS320F28004x](#), [TMS320F2807x](#) or [TMS320F2837x](#) microcontroller families) to decimate the output bitstream, the device can achieve 16 bits of resolution with a dynamic range of 86 dB at a data rate of 82 kSPS.

The internal reference source of the AMC1035 supports ratiometric circuit architecture to minimize the negative impact of the supply voltage variation and temperature drift on the accuracy of the measurement.

The AMC1035 can also be used for AC power line voltage sensing with a digital isolator and isolated power supply.

Device Information⁽¹⁾

PART NUMBER	PACKAGE	BODY SIZE (NOM)
AMC1035	SOIC (8)	4.9 mm \times 3.9 mm

(1) For all available packages, see the orderable addendum at the end of the datasheet.

Simplified Block Diagram

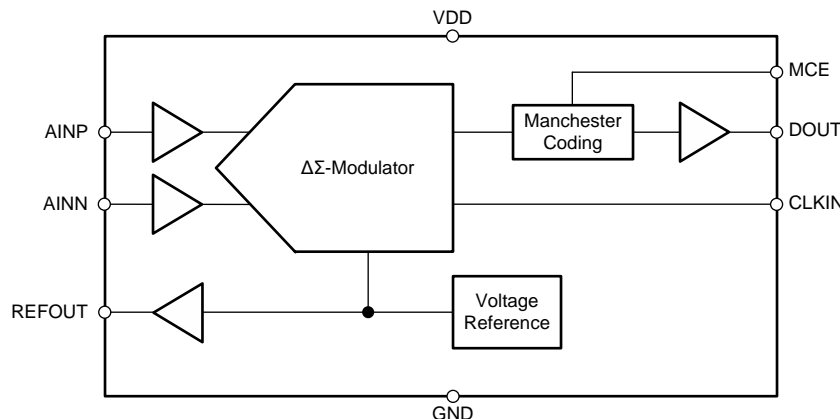


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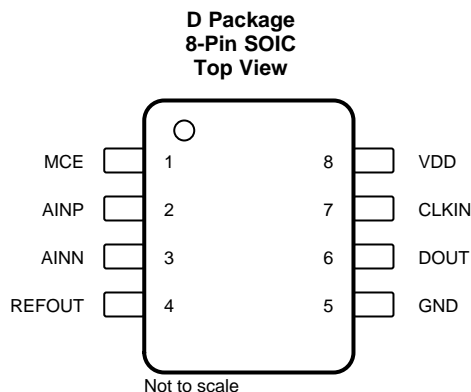
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4 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

DATE	REVISION	NOTES
August 2018	*	Initial release.

5 Pin Configuration and Functions



Pin Functions

PIN		I/O	DESCRIPTION
NO.	NAME		
1	MCE	I	Manchester coding enabled, active high, with internal pulldown resistor (typical value: 200 k Ω). The polarity of this signal must not be changed when the clock signal is applied.
2	AINP	I	Noninverting analog input.
3	AINN	I	Inverting analog input.
4	REFOUT	O	Reference output: 2.5 V nominal, maximum ± 5 -mA sink and source capability.
5	GND	—	Ground reference.
6	DOUT	O	Modulator bitstream data output, updated with the rising edge of the clock signal present on CLKIN. This pin is a Manchester coded output if MCE is pulled high. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device.
7	CLKIN	I	Modulator clock input: 9 MHz to 21 MHz with an internal pulldown resistor (typical value: 200 k Ω). The clock signal must be applied continuously for proper device operation; see the Clock Input section for additional details.
8	VDD	—	Power supply, 3.0 V to 5.5 V. See the Power Supply Recommendations section for decoupling recommendations.

6 Specifications

6.1 Absolute Maximum Ratings

 see ⁽¹⁾

	MIN	MAX	UNIT
Supply voltage, VDD to GND	−0.3	6.5	V
Analog input voltage at AINP, AINN	GND − 5	VDD + 0.5	V
Analog output voltage at REFOUT	GND − 0.5	VDD + 0.5	V
Digital input voltage at CLKIN or MCE	GND − 0.5	VDD + 0.5	V
Digital output voltage at DOUT	GND − 0.5	VDD + 0.5	V
Input current to any pin except supply pins	−10	10	mA
Junction temperature, T _J		150	°C
Storage temperature, T _{stg}	−65	150	°C

- (1) Stresses beyond those listed under *Absolute Maximum Ratings* may cause permanent damage to the device. These are stress ratings only, and do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Conditions*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

6.2 ESD Ratings

			VALUE	UNIT
V _(ESD)	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001 ⁽¹⁾	±2000	V
		Charged-device model (CDM), per JEDEC specification JESD22-C101 ⁽²⁾	±1000	

- (1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
 (2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

6.3 Recommended Operating Conditions

over operating ambient temperature range (unless otherwise noted)

				MIN	NOM	MAX	UNIT
POWER SUPPLY							
VDD	Supply voltage	VDD to GND		3.0	5.0	5.5	V
ANALOG INPUT							
V _{Clipping}	Differential input voltage before clipping output	V _{IN} = V _{AINP} − V _{AINN}		±1.25			V
V _{FSR}	Specified linear differential full-scale voltage	V _{IN} = V _{AINP} − V _{AINN}		−1		1	V
	Absolute common-mode input voltage ⁽¹⁾	(V _{AINP} + V _{AINN}) / 2 to GND		−2		VDD	V
V _{CM}	Operating common-mode input voltage	(V _{AINP} + V _{AINN}) / 2 to GND, 3.0 V ≤ VDD ≤ 4.5 V		−0.65		VDD − 2.35	V
		(V _{AINP} + V _{AINN}) / 2 to GND, 4.5 V ≤ VDD ≤ 5.5 V		−0.65		2.15	V
DIGITAL INPUT							
	Input voltage	V _{MCE} or V _{CLKIN} to GND		GND		VDD	V
TEMPERATURE RANGE							
T _A	Operating ambient temperature			−40		125	°C

- (1) Steady-state voltage supported by the device in case of a system failure. See specified common-mode input voltage V_{CM} for normal operation. Observe analog input voltage range as specified in [Absolute Maximum Ratings](#) table.

6.4 Thermal Information

THERMAL METRIC ⁽¹⁾		AMC1035	
		D (SOIC)	
		8 PINS	
			UNIT
R _{θJA}	Junction-to-ambient thermal resistance	120	°C/W
R _{θJC(top)}	Junction-to-case (top) thermal resistance	52	°C/W
R _{θJB}	Junction-to-board thermal resistance	61	°C/W
ψ _{JT}	Junction-to-top characterization parameter	10	°C/W
ψ _{JB}	Junction-to-board characterization parameter	60	°C/W
R _{θJC(bot)}	Junction-to-case (bottom) thermal resistance	n/a	°C/W

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

6.5 Electrical Characteristics

minimum and maximum specifications apply from T_A = –40°C to +125°C, VDD = 3.0 V to 5.5 V, AINP = –1 V to 1 V, AINN = GND, and sinc³ filter with OSR = 256 (unless otherwise noted); typical specifications are at T_A = 25°C, CLKIN = 20 MHz, and VDD = 3.3 V

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
ANALOG INPUTS						
V _{CMuv}	Negative common-mode undervoltage detection level ⁽¹⁾	(V _{AINP} + V _{AINN}) / 2 ≠ 0 V		–1.05		V
		(V _{AINP} + V _{AINN}) / 2 = 0 V		–1.7		V
V _{CMov}	Positive common-mode overvoltage detection level ⁽¹⁾	3.0 V ≤ VDD ≤ 3.6 V, (V _{AINP} + V _{AINN}) / 2 ≠ 0 V,		VDD – 2.25		V
		3.0 V ≤ VDD ≤ 3.6 V, (V _{AINP} + V _{AINN}) / 2 = 0 V		VDD – 1.15		V
		4.5 V ≤ VDD ≤ 5.5 V, (V _{AINP} + V _{AINN}) / 2 ≠ 0 V		2.3		V
		4.5 V ≤ VDD ≤ 5.5 V, (V _{AINP} + V _{AINN}) / 2 = 0 V		2.9		V
R _{IN}	Single-ended input resistance	AINN = GND		1		GΩ
R _{IND}	Differential input resistance			1		GΩ
I _B	Input bias current	AINP = AINN = GND, (I _{AINP} + I _{AINN}) / 2		–2.5		nA
TCl _B	Input bias current thermal drift	AINP = AINN = GND, (I _{AINP} + I _{AINN}) / 2		±10		pA/°C
I _{IO}	Input offset current	I _{IO} = I _{AINP} – I _{AINN}		±1		nA
DC ACCURACY						
DNL	Differential nonlinearity	Resolution: 16 bits	–0.99		0.99	LSB
INL	Integral nonlinearity ⁽²⁾	Resolution: 16 bits	–12	±3	12	LSB
E _O	Offset error	Initial, at T _A = 25°C, AINP = AINN = GND	–0.5	±0.01	0.5	mV
TCE _O	Offset error thermal drift ⁽³⁾		–8		8	μV/°C
E _G	Gain error	Initial, at T _A = 25°C	–0.25%	±0.01%	0.25%	
TCE _G	Gain error thermal drift ⁽⁴⁾		–40	±20	40	ppm/°C

(1) The common-mode overvoltage detection level has a typical hysteresis of 90 mV.

(2) Integral nonlinearity is defined as the maximum deviation from a straight line passing through the end-points of the ideal ADC transfer function expressed as number of LSBs or as a percent of the specified linear full-scale range FSR.

(3) Offset error drift is calculated using the box method, as described by the following equation:

$$TCE_o = \frac{value_{MAX} - value_{MIN}}{TempRange}$$

(4) Gain error drift is calculated using the box method, as described by the following equation:

$$TCE_G(ppm) = \left(\frac{value_{MAX} - value_{MIN}}{value \times TempRange} \right) \times 10^6$$

Electrical Characteristics (continued)

minimum and maximum specifications apply from $T_A = -40^\circ\text{C}$ to $+125^\circ\text{C}$, $V_{DD} = 3.0\text{ V}$ to 5.5 V , $A_{INP} = -1\text{ V}$ to 1 V , $A_{INN} = \text{GND}$, and sinc³ filter with $\text{OSR} = 256$ (unless otherwise noted); typical specifications are at $T_A = 25^\circ\text{C}$, $\text{CLKIN} = 20\text{ MHz}$, and $V_{DD} = 3.3\text{ V}$

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
AC ACCURACY						
SNR	Signal-to-noise ratio	$f_{IN} = 1\text{ kHz}$		86		dB
SINAD	Signal-to-noise + distortion	$f_{IN} = 1\text{ kHz}$		86		dB
THD	Total harmonic distortion	$f_{IN} = 1\text{ kHz}$		-95		dB
SFDR	Spurious-free dynamic range	$f_{IN} = 1\text{ kHz}$		-92		dB
REFERENCE OUTPUT						
V_{REFOUT}	Reference output voltage	Initial, at $T_A = 25^\circ\text{C}$, no load	2.495	2.5	2.505	V
TCV_{REFOUT}	Reference output voltage drift		-50	± 10	50	ppm/ $^\circ\text{C}$
PSRR	Power-supply rejection ratio	$-40^\circ\text{C} \leq T_A \leq 85^\circ\text{C}$	-300	± 15	300	$\mu\text{V/V}$
		$-40^\circ\text{C} \leq T_A \leq 125^\circ\text{C}$	-700	± 15	700	
I_{REFOUT}	Reference output current	$C_{LOAD} < 1\text{ nF}^{(5)}$	-5		5	mA
	Load regulation	Load to GND or VDD		0.15	0.35	mV/mA
I_{SC}	Short-circuit current	REFOUT to GND		-18		mA
		REFOUT to VDD		20		
DIGITAL INPUT (CMOS Logic With Schmitt-Trigger)						
I_{IN}	Input current	$\text{GND} \leq V_{IN} \leq \text{VDD}$	0		7	μA
C_{IN}	Input capacitance			4		pF
V_{IH}	High-level input voltage		$0.7 \times \text{VDD}$		$\text{VDD} + 0.3$	V
V_{IL}	Low-level input voltage		-0.3		$0.3 \times \text{VDD}$	V
DIGITAL OUTPUT: CMOS						
C_{LOAD}	Output load capacitance	$f_{CLKIN} = 21\text{ MHz}$		15	30	pF
V_{OH}	High-level output voltage	$I_{OH} = -20\ \mu\text{A}$	$\text{VDD} - 0.1$			V
		$I_{OH} = -4\text{ mA}$	$\text{VDD} - 0.4$			
V_{OL}	Low-level output voltage	$I_{OL} = 20\ \mu\text{A}$			0.1	V
		$I_{OL} = 4\text{ mA}$			0.4	
POWER SUPPLY						
VDD	Supply voltage		3.0	5.0	5.5	V
I_{VDD}	High-side supply current	$3.0\text{ V} \leq \text{VDD} \leq 3.6\text{ V}$, $I_{REFOUT} = 0\text{ mA}$, $\text{MCE} = 0$, $C_{LOAD} = 15\text{ pF}$		5.5		mA
		$3.0\text{ V} \leq \text{VDD} \leq 3.6\text{ V}$, $I_{REFOUT} = 0\text{ mA}$, $\text{MCE} = 1$, $C_{LOAD} = 15\text{ pF}$		4.6		
		$4.5\text{ V} \leq \text{VDD} \leq 5.5\text{ V}$, $I_{REFOUT} = 0\text{ mA}$, $\text{MCE} = 0$, $C_{LOAD} = 15\text{ pF}$		6.5	10	
		$4.5\text{ V} \leq \text{VDD} \leq 5.5\text{ V}$, $I_{REFOUT} = 0\text{ mA}$, $\text{MCE} = 1$, $C_{LOAD} = 15\text{ pF}$		5.6	11	

(5) Capacitive load with a value $\geq 1\text{ nF}$ requires series resistor to be connected to the REFOUT pin.

6.6 Switching Characteristics

over operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS	MIN	TYP	MAX	UNIT
f _{CLKIN}	CLKIN clock frequency	MCE = 0	9	20	21	MHz
		MCE = 1	9	10	11	
Duty _{Cycle}	CLKIN clock duty cycle	MCE = 0	42%	50%	58%	
		MCE = 1	45%	50%	55%	
t _{H1}	DOUT hold time after rising edge of CLKIN	MCE = 0, C _{LOAD} = 15 pF	4.5			ns
t _{H2}	DOUT hold time after rising edge of CLKIN	MCE = 1, C _{LOAD} = 15 pF	5		17	ns
t _{H3}	DOUT hold time after falling edge of CLKIN	MCE = 1, C _{LOAD} = 15 pF	11		25	ns
t _{D1}	Rising edge of CLKIN to DOUT valid delay	MCE = 0, C _{LOAD} = 15 pF			23	ns
t _{D2}	Rising edge of CLKIN to DOUT valid delay	MCE = 1, C _{LOAD} = 15 pF	9		24	ns
t _{D3}	Falling edge of CLKIN to DOUT valid delay	MCE = 1, C _{LOAD} = 15 pF	29		31	ns
t _{ASTART}	Analog startup time	VDD step to 3.0 V, 0.1% settling, CLKIN applied		0.2		ms

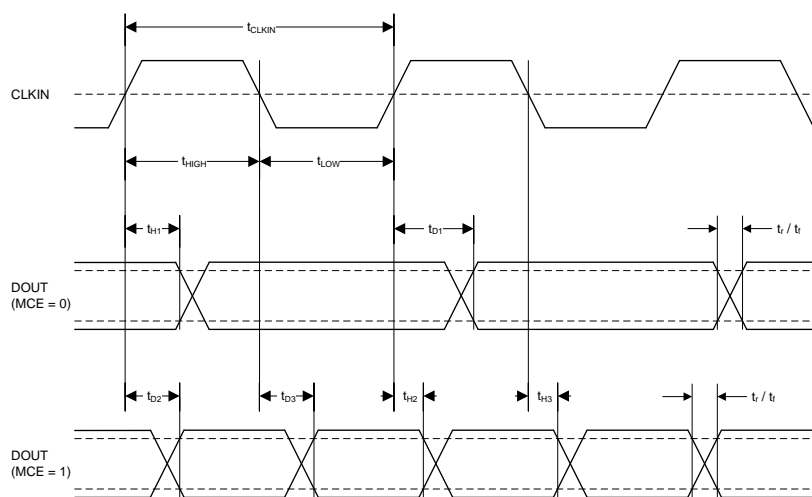


Figure 1. Digital Interface Timing

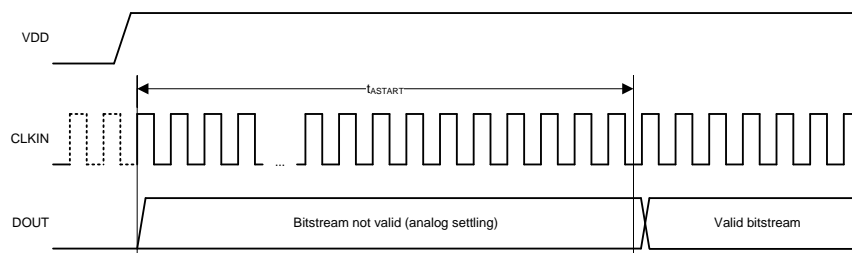


Figure 2. Device Startup Timing

ADVANCE INFORMATION

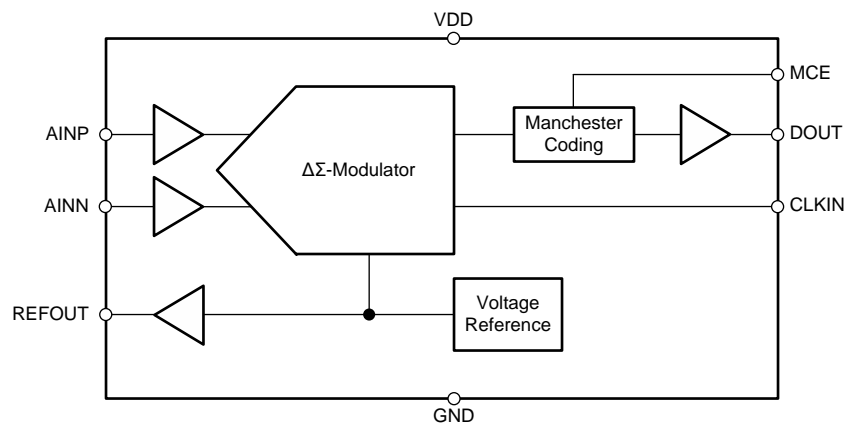
7 Detailed Description

7.1 Overview

The differential analog input (comprised of input signals AINP and AINN) of the AMC1035 is a chopper-stabilized buffer, followed by the switched-capacitor input of a second-order, delta-sigma ($\Delta\Sigma$) modulator stage that digitizes the input signal into a 1-bit output stream. The data output DOUT of the converter provides a stream of digital ones and zeros that is synchronous to the externally-provided clock source at the CLKIN pin with a frequency in the range of 9 MHz to 21 MHz. The time average of this serial bitstream output is proportional to the analog input voltage.

The [Functional Block Diagram](#) section shows a detailed block diagram of the AMC1035. The 1-G Ω input resistance of the analog input stage supports low gain-error signal sensing in high-voltage applications using resistive dividers. The external clock input simplifies the synchronization of multiple measurement channels on the system level. The extended frequency range of up to 21 MHz supports higher performance levels compared to the other solutions available on the market.

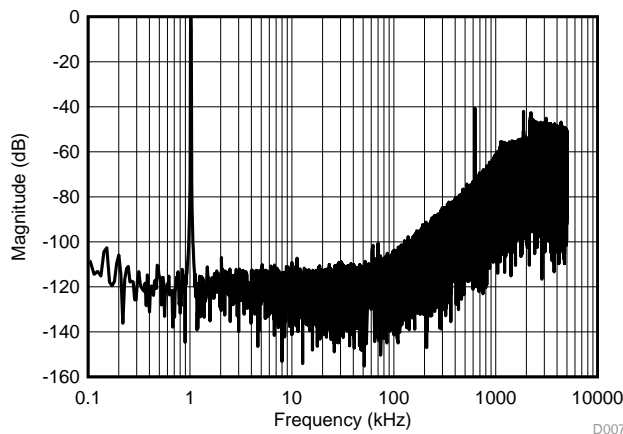
7.2 Functional Block Diagram



7.3 Feature Description

7.3.1 Analog Input

The AMC1035 incorporates front-end circuitry that contains a buffered sampling stage, followed by a $\Delta\Sigma$ modulator. To support a bipolar input range, the device uses a charge pump that allows single-supply operation to simplify the overall system design and minimize the circuit cost. For reduced offset and offset drift, the input buffer is chopper-stabilized with the switching frequency set at $f_{CLKIN} / 32$. Figure 3 shows the spur created by the switching frequency.



sinc^3 filter, $\text{OSR} = 2$, $f_{CLKIN} = 20 \text{ MHz}$, $f_{IN} = 1 \text{ kHz}$

Figure 3. Quantization Noise Shaping

There are two restrictions on the analog input signals (AINP and AINN). First, if the input voltage exceeds the range $\text{AGND} - 5 \text{ V}$ to $\text{AVDD} + 0.5 \text{ V}$, the input current must be limited to 10 mA because the device input electrostatic discharge (ESD) diodes turn on. In addition, the linearity and noise performance of the device are ensured only when the differential analog input voltage remains within the specified linear full-scale range (FSR), that is $\pm 1 \text{ V}$, and within the specified input common-mode range.

Feature Description (continued)

7.3.2 Modulator

The modulator implemented in the AMC1035 (such as the one conceptualized in [Figure 4](#)) is a second-order, switched-capacitor, feed-forward $\Delta\Sigma$ modulator. The analog input voltage V_{IN} and the output V_5 of the 1-bit digital-to-analog converter (DAC) are differentiated, providing an analog voltage V_1 at the input of the first integrator stage. The output of the first integrator feeds the input of the second integrator stage, resulting in output voltage V_3 that is differentiated with the input signal V_{IN} and the output of the first integrator V_2 . Depending on the polarity of the resulting voltage V_4 , the output of the comparator is changed. In this case, the 1-bit DAC responds on the next clock pulse by changing the associated analog output voltage V_5 , causing the integrators to progress in the opposite direction and forcing the value of the integrator output to track the average value of the input.

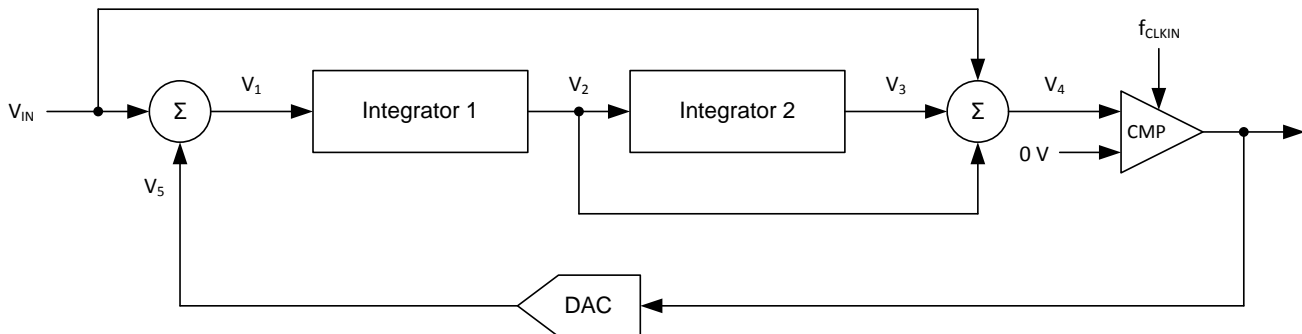


Figure 4. Block Diagram of a Second-Order Modulator

As depicted in [Figure 3](#), the modulator shifts the quantization noise to high frequencies. Therefore, use a low-pass digital filter at the output of the device to increase the overall performance. This filter is also used to convert from the 1-bit data stream at a high sampling rate into a higher-bit data word at a lower rate (decimation). TI's microcontroller families [TMS320F28004x](#), [TMS320F2807x](#), and [TMS320F2837x](#) offer a suitable programmable, hardwired filter structure termed a *sigma-delta filter module* (SDFM) optimized for usage with the AMC1035. Also, SD24_B converters on the [MSP430F677x](#) microcontrollers offer a path to directly access the integrated sinc-filters for a simple system-level solution for multichannel, isolated current sensing. An additional option is to use a suitable application-specific device, such as the [AMC1210](#) (a four-channel digital sinc filter). Alternatively, a field-programmable gate array (FPGA) can be used to implement the filter.

7.3.3 Clock Input

The AMC1035 system clock is provided externally at the CLKIN pin. The clock signal can be applied and paused at any time. When the clock signal is paused, the modulator stops the analog signal conversion and the digital output signal remains frozen in the last logic state. When the clock signal is applied again after a pause, the internal analog circuitry biasing must settle for proper device performance. In this case, consider the t_{ASTART} specification in the [Switching Characteristics](#) table.

Feature Description (continued)

7.3.4 Digital Output

A differential input signal of 0 V ideally produces a stream of ones and zeros that are high 50% of the time. A differential input of 1 V produces a stream of ones and zeros that are high 90% of the time. With 16 bits of resolution, that percentage ideally corresponds to code 58982 (an unsigned code). A differential input of –1 V produces a stream of ones and zeros that are high 10% of the time and ideally results in code 6553 with 16-bit resolution. These input voltages are also the specified linear range of the AMC1035 with performance as specified in this document. If the input voltage value exceeds these range, the output of the modulator shows nonlinear behavior when the quantization noise increases. The output of the modulator clips with a stream of only zeros with an input less than or equal to –1.25 V or with a stream of only ones with an input greater than or equal to 1.25 V. In this case, however, the AMC1035 generates a single 1 (if the input is at negative full-scale) or 0 every 128 clock cycles to indicate proper device function (see the [Fail-Safe Output](#) section for more details). [Figure 5](#) shows the input voltage versus the output modulator signal.

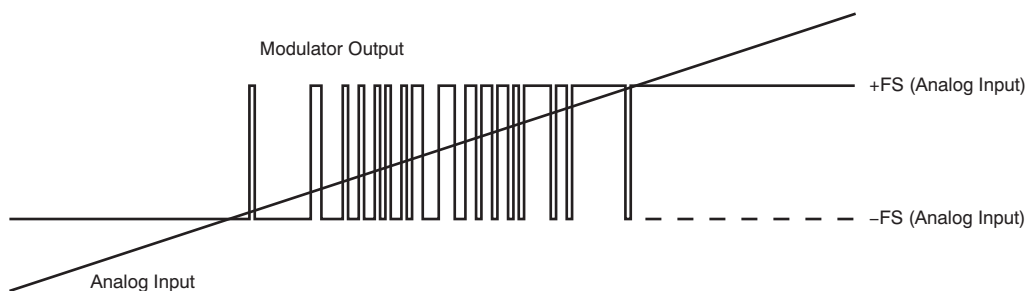


Figure 5. Analog Input versus the AMC1035 Modulator Output

[Equation 1](#) calculates the density of ones in the output bitstream for any input voltage value (with the exception of a full-scale input signal, as described in the [Output Behavior in Case of a Full-Scale Input](#) section):

$$\frac{V_{IN} + V_{Clipping}}{2 \times V_{Clipping}} \quad (1)$$

The modulator bitstream on the DOUT pin changes with the rising edge of the clock signal applied on the CLKIN pin. Use the rising edge of the clock to latch the modulator bitstream at the input of the digital filter device.

7.3.5 Manchester Coding Feature

The AMC1035 offers the IEEE 802.3-compliant Manchester coding feature that generates at least one transition per bit to support clock signal recovery from the bitstream. The Manchester coding combines the clock and data information using exclusive or (XOR) logical operation that results in a bitstream free of DC components. [Figure 6](#) shows the resulting bitstream from this coding. The duty cycle of the Manchester encoded bitstream depends on the duty cycle of the input clock CLKIN. To enable Manchester coding on the AMC1035, pull the input pin MCE high.

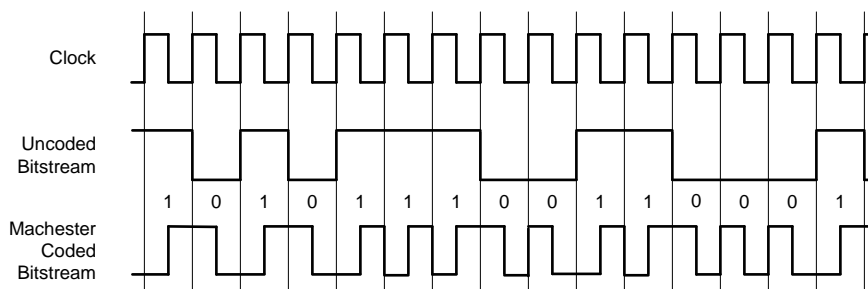


Figure 6. Manchester Coded Output of the AMC1035

7.4 Device Functional Modes

The AMC1035 is operational when the power supply VDD and clock signal CLKIN are applied, as specified in the [Recommended Operating Conditions](#) and [Switching Characteristics](#) tables.

7.4.1 Output Behavior in Case of a Full-Scale Input

If a full-scale input signal is applied to the AMC1035 (that is, $V_{IN} \geq V_{Clipping}$), the device generates a single one or zero every 128 bits at DOUT, as shown in [Figure 7](#), depending on the actual polarity of the signal being sensed. This feature is also supported with Manchester-coded output and allows full-scale and invalid input signals to be identified as described in the [Fail-Safe Output](#) section and can be used for advanced system-level diagnostics.

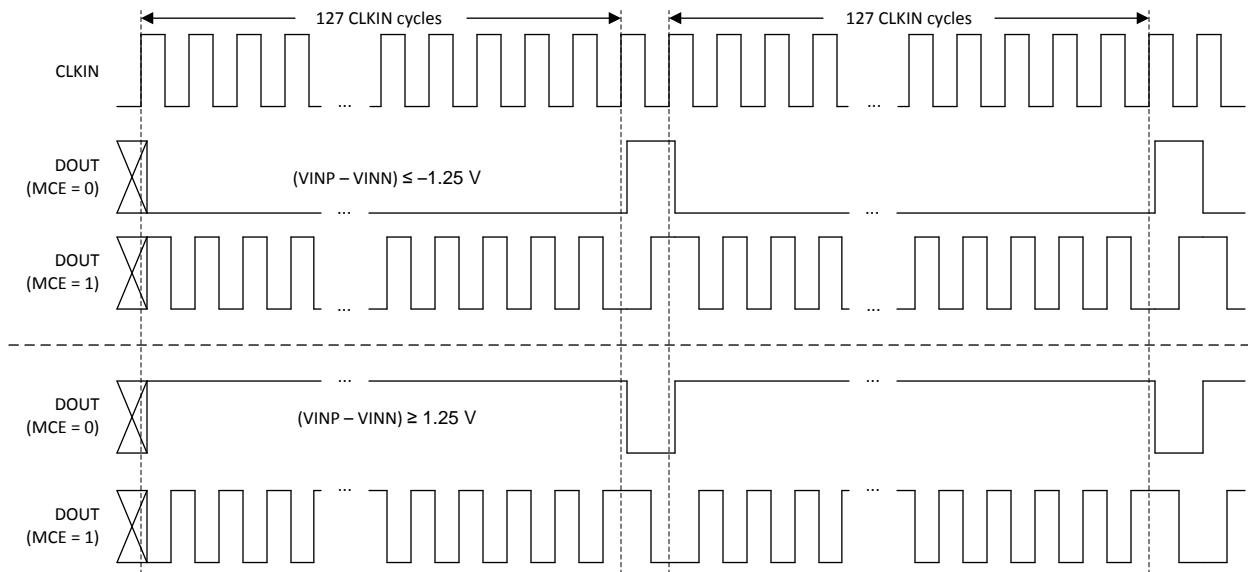


Figure 7. Overrange Output of the AMC1035

7.4.2 Fail-Safe Output

[Figure 8](#) shows that if the common-mode voltage of the input reaches or exceeds the specified common-mode undervoltage, V_{CMUV} , or overvoltage detection level, V_{CMOV} as defined in the [Electrical Characteristics](#) table, the DOUT of the AMC1035 is held at steady-state high.

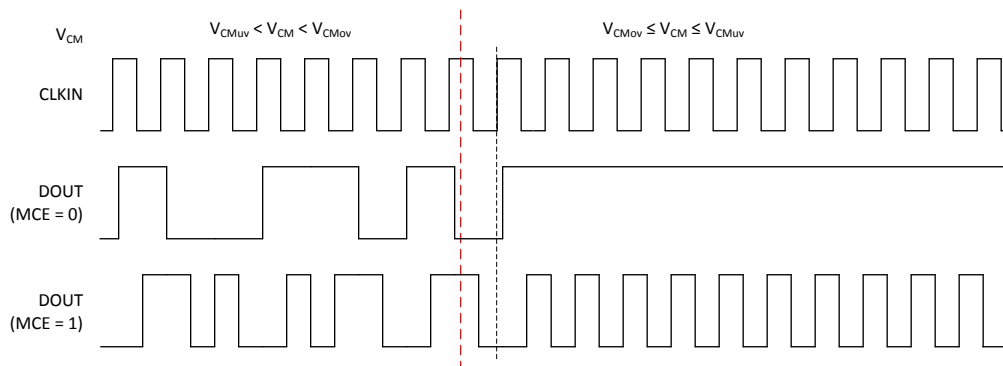


Figure 8. Fail-Safe Output of the AMC1035

8 Application and Implementation

NOTE

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

8.1 Application Information

8.1.1 Digital Filter Usage

The modulator generates a bitstream that is processed by a digital filter to obtain a digital word similar to a conversion result of a conventional analog-to-digital converter (ADC). [Equation 2](#) shows a sinc³-type filter, which is a very simple filter, built with minimal effort and hardware:

$$H(z) = \left(\frac{1 - z^{-OSR}}{1 - z^{-1}} \right)^3 \quad (2)$$

This filter provides the best output performance at the lowest hardware size (count of digital gates) for a second-order modulator. All the characterization in this document is also done with a sinc³ filter with an oversampling ratio (OSR) of 256 and an output word width of 16 bits.

An example code for implementing a sinc³ filter in an FPGA is discussed in the [Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications](#) application note, available for download at www.ti.com.

8.2 Typical Applications

8.2.1 Voltage Sensing

$\Delta\Sigma$ modulators are widely used in frequency inverter designs because of their high AC and DC performance. Frequency inverters are critical parts of industrial motor drives, photovoltaic inverters (string and central inverters), uninterruptible power supplies (UPS), and other industrial applications.

Figure 9 shows a simplified schematic of a motor drive application with the AMC1035 used for the DC-link and output phase voltage sensing. In this example, all resistive dividers reference to the negative DC-link voltage that is also used as a ground reference point for the microcontroller. An additional fifth AMC1035 can be used for temperature sensing of the insulated-gate bipolar transistor (IGBT) module; see the [IGBT Temperature Sensing](#) section for more details.

Current feedback is performed with shunt resistors (R_{SHUNT}) and TI's [AMC1306M25](#) isolated modulators. Depending on the system design, either all three or only two motor phase currents are sensed.

Depending on the overall digital processing power requirements and with a total of eight $\Delta\Sigma$ modulator bitstreams to be processed by the MCU, a derivate from either the low-cost single-core [TMS320F2807x](#) or the dual-core [TMS320F2837x](#) families can be used in this application.

ADVANCE INFORMATION

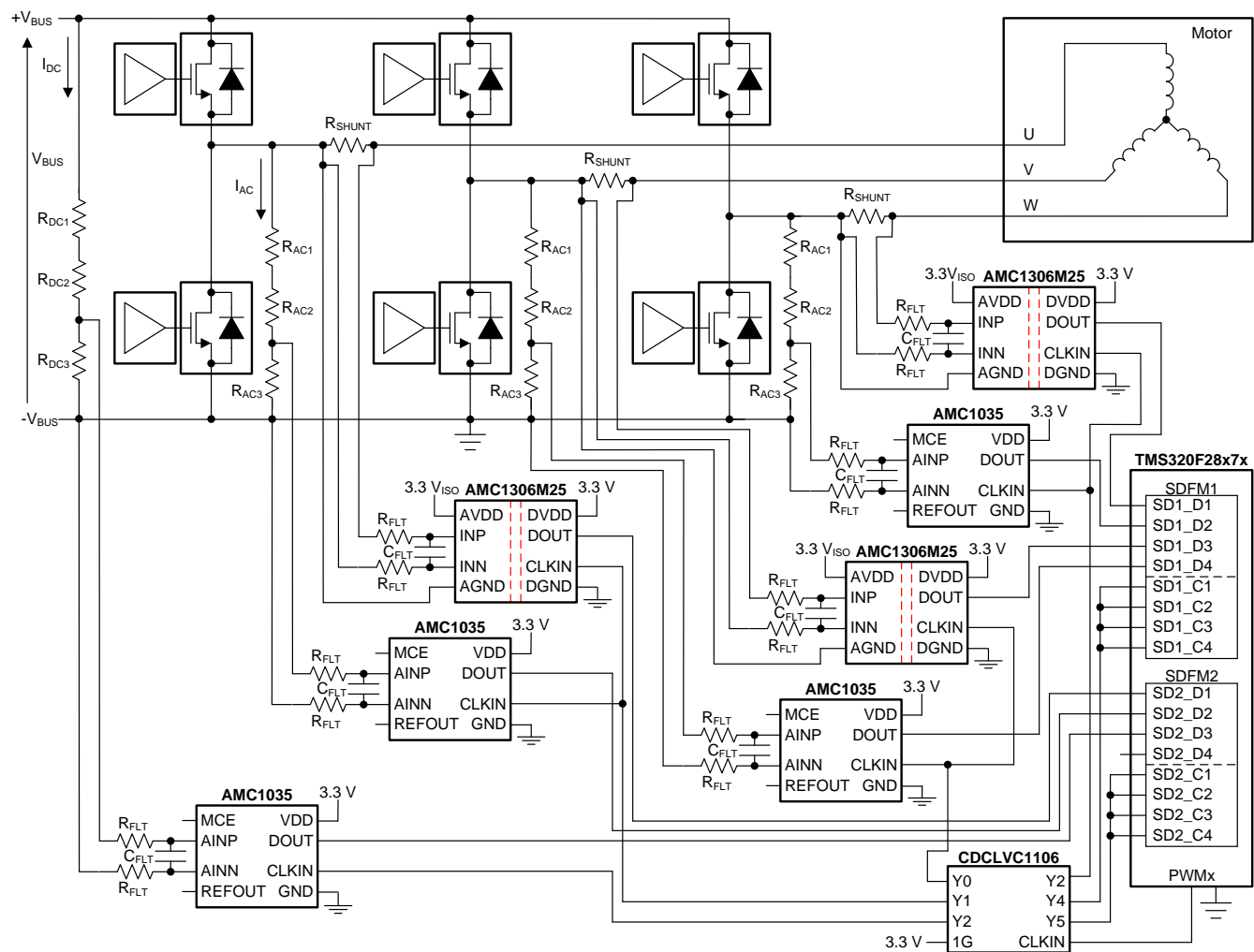


Figure 9. The AMC1035 in a Frequency Inverter Application

Typical Applications (continued)

8.2.1.1 Design Requirements

Table 1 lists the parameters for this typical application.

Table 1. Design Requirements

PARAMETER	VALUE
Supply voltage	3.3 V
Voltage drop across the sensing resistor R_{DC1} for a linear response	1 V (maximum)
Voltage drop across the sensing resistors R_{ACx} for a linear response	± 1 V (maximum)
Current through the sensing resistors R_{ACx}	± 100 μ V (maximum)

8.2.1.2 Detailed Design Procedure

Use Ohm's Law to calculate the minimum total resistance of the resistive dividers to limit the cross current to the desired values:

- For the voltage sensing on the DC bus: $R_{DC1} + R_{DC2} + R_{DC3} = V_{BUS} / I_{DC}$
- For the voltage sensing on the output phases U, V, and W: $R_{AC1} + R_{AC2} + R_{AC3} = V_{PHASE (max)} / I_{AC}$

Consider the following two restrictions to choose the proper value of the resistors R_{DC3} and R_{AC3} :

- The voltage drop caused by the nominal voltage range of the system must not exceed the recommended input voltage range of the AMC1035: $V_{XC3} \leq V_{FSR}$
- The voltage drop caused by the maximum allowed system overvoltage must not exceed the input voltage that causes a clipping output: $V_{XC3} \leq V_{Clipping}$

Use similar approach for calculation of the shunt resistor values R_{SHUNT} and refer to the datasheet of the [AMC1306M25](#) for further details.

Table 2 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 600 V and 800 V on the DC bus.

Table 2. Resistor Value Examples for DC Bus Sensing

PARAMETER	600-V DC BUS	800-V DC Bus
Resistive divider resistor R_{DC1}	3.01 M Ω	4.22 M Ω
Resistive divider resistor R_{DC2}	3.01 M Ω	4.22 M Ω
Sense resistor R_{DC3}	10 k Ω	10.5 k Ω
Resulting current through resistive divider I_{DC}	99.5 μ A	94.7 μ A
Resulting voltage drop on sense resistor V_{RDC3}	0.995 V	0.994 V

Table 3 lists examples of nominal E96-series (1% accuracy) resistor values for systems using 230 V and 690 V on the output phases.

Table 3. Resistor Value Examples for Output Phase Voltage Sensing

PARAMETER	± 400 -V _{AC} PHASE	± 690 -V _{AC} PHASE
Resistive divider resistor R_{AC1}	2.0 M Ω	3.48 M Ω
Resistive divider resistor R_{AC2}	2.0 M Ω	3.48 M Ω
Sense resistor R_{AC3}	10.0 k Ω	10.0 k Ω
Resulting current through resistive divider I_{AC}	99.8 μ A	99.0 μ A
Resulting voltage drop on sense resistor V_{RAC3}	± 0.998 V	± 0.990 V

Use a power supply with a nominal voltage of 3.3 V to directly connect all modulators to the microcontroller.

For modulator output bitstream filtering, a device from TI's [TMS320F2807x](#) family of low-cost microcontrollers (MCUs) or [TMS320F2837x](#) family of dual-core MCUs is recommended. These MCU families support up to eight channels of dedicated hardwired filter structures called sigma-delta filter modules (SDFMs) that significantly simplify system level design by offering two filtering paths per channel: one providing high accuracy results for the control loop and one that offers a fast response path for overcurrent detection. Use one of the pulse-width modulation (PWM) sources inside the MCU to generate the clock for the modulators and for easy synchronization of all feedback signals and the switching control of the gate drivers.

[Figure 9](#) uses a clock buffer to distribute the clock reference signal generated on one of the PWM outputs of the MCU (called PWMx in [Figure 9](#)) to all modulators used in the circuit and as a reference for the digital filters in the MCU. In this example, TI's [CDCLVC1106](#) is used for this purpose. Each CDCLVC1106 output can drive a load of 8 μ F that is sufficient to drive up to two modulator and up to four SDFM clock inputs.

8.2.2 IGBT Temperature Sensing

The high input impedance of the AMC1035 is optimized for usage in voltage-sensing applications. Additionally, the internal voltage reference supports temperature sensing using a positive temperature coefficient (PTC) or a negative temperature coefficient (NTC) sensor often integrated in the IGBT module.

The same reference is internally used by the modulator, resulting in a ratiometric system solution that minimizes the overall temperature drift of the sensing path. [Figure 10](#) shows a simplified schematic of the AMC1035 used for temperature sensing of the IGBT module.

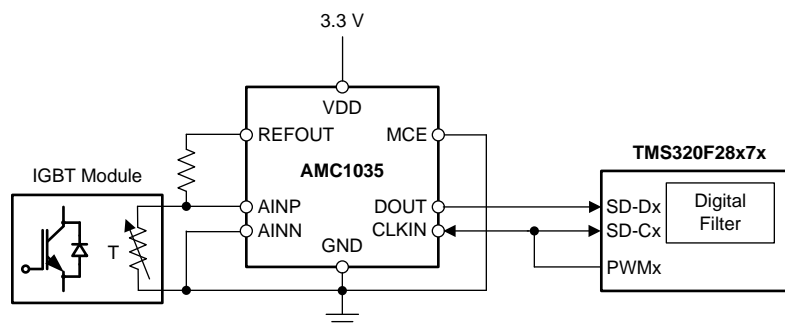


Figure 10. Using the AMC1035 for Temperature Sensing

8.2.3 What to Do and What Not to Do

Do not leave the inputs of the AMC1035 unconnected (floating) when the device is powered up. If both modulator inputs are left floating, the input bias current drives these inputs to the output common-mode of the analog front-end of approximately 2 V. If that voltage is above the specified input common-mode range, the front gain diminishes and the modulator outputs a bitstream resembling a zero input differential voltage.

9 Power Supply Recommendations

In a typical frequency-inverter application, the high-side power supply (AVDD) for the device is directly derived from the floating power supply of the upper gate driver. For lowest system-level cost, a Zener diode can be used to limit the voltage to 5 V or 3.3 V ($\pm 10\%$). Alternatively a low-cost low-drop regulator (LDO), for example the [LM317-N](#), can be used to adjust the supply voltage level and minimize noise on the power-supply node. A low-ESR decoupling capacitor of 0.1 μF is recommended for filtering this power-supply path. Place this capacitor (C2 in [Figure 11](#)) as close as possible to the AVDD pin of the AMC1035 for best performance. If better filtering is required, an additional 10- μF capacitor can be used.

The floating ground reference (AGND) is derived from the end of the shunt resistor that is connected to the negative input (AINN) of the device. If a four-pin shunt is used, the device inputs are connected to the inner leads and AGND is connected to one of the outer leads of the shunt.

For decoupling of the power supply, a 0.1- μF capacitor is recommended to be placed as close to the VDD pin of the AMC1035 as possible, followed by an additional capacitor in the range of 1 μF to 10 μF .

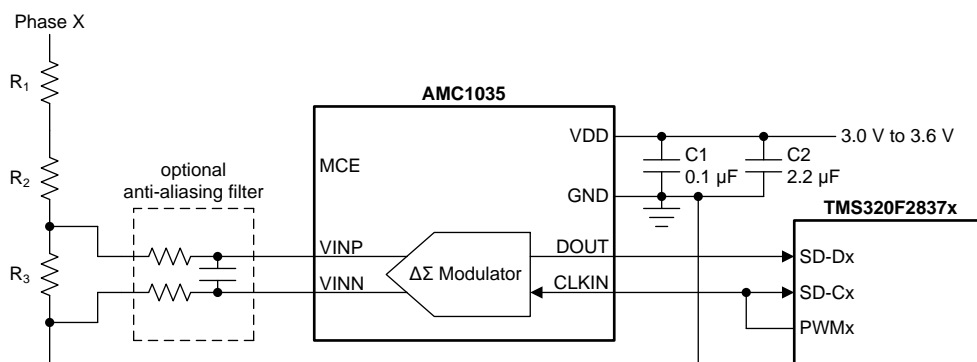


Figure 11. Decoupling the AMC1035

10 Layout

10.1 Layout Guidelines

Figure 12 shows two layout recommendations for designs based on 1206-SMD or 0603-SMD size decoupling capacitors placed as close as possible to the AMC1035. For best performance, place the AMC1035 as close as possible to the source of the analog signal to be converted and keep the layout of the VINP and VINN traces symmetrical.

10.2 Layout Example

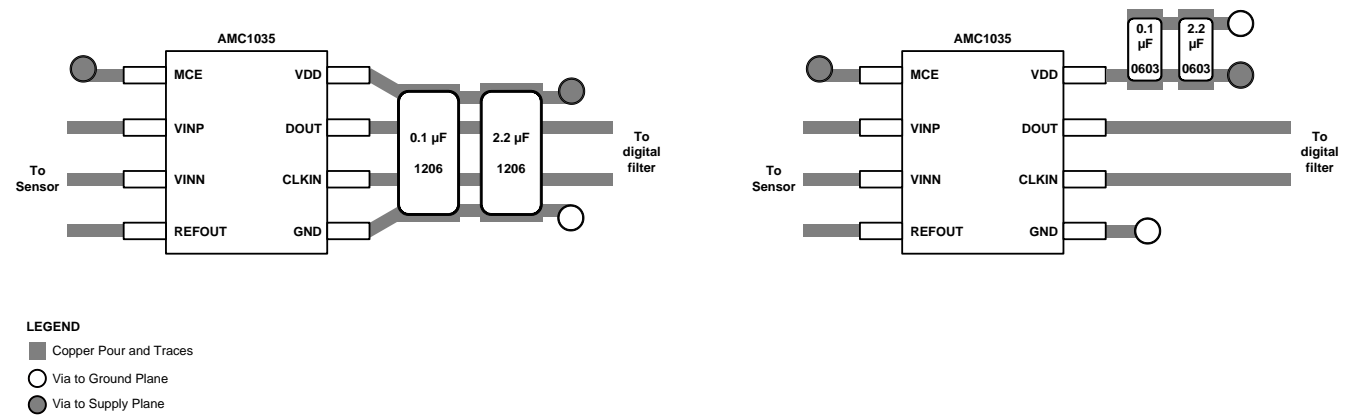


Figure 12. Recommended Layout of the AMC1035

11 Device and Documentation Support

11.1 Documentation Support

11.1.1 Related Documentation

For related documentation see the following:

- [AMC1210 Quad Digital Filter for 2nd-Order Delta-Sigma Modulator](#)
- [AMC1306x Small, High-Precision, Reinforced Isolated Delta-Sigma Modulators With High CMTI](#)
- [MSP430F677x Polyphase Metering SoCs](#)
- [TMS320F28004x Piccolo™ Microcontrollers](#)
- [TMS320F2807x Piccolo™ Microcontrollers](#)
- [TMS320F2837xD Dual-Core Delfino™ Microcontrollers](#)
- [Combining the ADS1202 with an FPGA Digital Filter for Current Measurement in Motor Control Applications](#)
- [CDCLVC11xx 3.3-V and 2.5-V LVCMOS High-Performance Clock Buffer Family](#)
- [LM117, LM317-N Wide Temperature Three-Pin Adjustable Regulator](#)

11.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. In the upper right corner, click on *Alert me* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

11.3 Community Resources

The following links connect to TI community resources. Linked contents are provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's [Terms of Use](#).

TI E2E™ Online Community *TI's Engineer-to-Engineer (E2E) Community*. Created to foster collaboration among engineers. At e2e.ti.com, you can ask questions, share knowledge, explore ideas and help solve problems with fellow engineers.

Design Support *TI's Design Support* Quickly find helpful E2E forums along with design support tools and contact information for technical support.

11.4 Trademarks

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11.5 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

11.6 Glossary

[SLYZ022](#) — *TI Glossary*.

This glossary lists and explains terms, acronyms, and definitions.

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
PAMC1035D	ACTIVE	SOIC	D	8	75	TBD	Call TI	Call TI	-40 to 125		Samples
PAMC1035DR	ACTIVE	SOIC	D	8	2500	TBD	Call TI	Call TI	-40 to 125		Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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